

# PQMB11

PNP/PNP resistor-equipped transistors; R1 = 10 k $\Omega$ , R2 = 10 k $\Omega$ 26 October 2015

**Product data sheet** 

### 1. General description

PNP/PNP Resistor-Equipped Transistors (RET) in a leadless ultra small DFN1010B-6 (SOT1216) Surface-Mounted Device (SMD) plastic package.

NPN/NPN complement: PQMH11.

NPN/PNP complement: PQMD3.

### 2. Features and benefits

- 100 mA output current capability
- Built-in bias resistors
- Simplifies circuit design
- Low package height of 0.37 mm
- Reduces component count
- Reduces pick and place costs
- AEC-Q101 qualified

### 3. Applications

- Low current peripheral driver
- Control of IC inputs
- Replaces general-purpose transistors in digital applications
- Mobile applications

### 4. Quick reference data

| Table 1. Qu      | uick reference data          |                          |     |     |     |      |      |
|------------------|------------------------------|--------------------------|-----|-----|-----|------|------|
| Symbol           | Parameter                    | Conditions               |     | Min | Тур | Мах  | Unit |
| Per transistor   |                              |                          |     |     |     |      |      |
| V <sub>CEO</sub> | collector-emitter<br>voltage | open base                |     | -   | -   | -50  | V    |
| I <sub>O</sub>   | output current               |                          |     | -   | -   | -100 | mA   |
| Per transisto    | r                            |                          | I   |     |     | _    |      |
| R1               | bias resistor 1              | T <sub>amb</sub> = 25 °C | [1] | 7   | 10  | 13   | kΩ   |
| R2/R1            | bias resistor ratio          |                          | [1] | 0.8 | 1   | 1.2  |      |

[1] See section "Test information" for resistor calculation and test conditions.





# 5. Pinning information

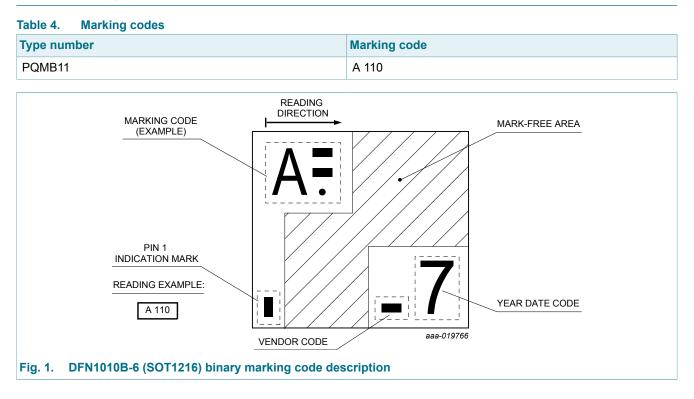
| Table 2. | Pinning | information            |                      |                          |
|----------|---------|------------------------|----------------------|--------------------------|
| Pin      | Symbol  | Description            | Simplified outline   | Graphic symbol           |
| 1        | GND1    | GND (emitter) TR1      |                      | 01 I2 GND2               |
| 2        | 11      | input ( base) TR1      |                      |                          |
| 3        | 02      | output (collector) TR2 | 2 5                  |                          |
| 4        | GND2    | GND (emitter) TR2      |                      |                          |
| 5        | 12      | input ( base) TR2      |                      |                          |
| 6        | 01      | output (collector) TR1 | Transparent top view |                          |
| 7        | 01      | output (collector) TR1 | DFN1010B-6 (SOT1216) | GND1 I1 O2<br>aaa-019790 |
| 8        | 02      | output (collector) TR2 |                      |                          |

# 6. Ordering information

| Table 3. Ordering information |            |  |         |  |  |  |  |
|-------------------------------|------------|--|---------|--|--|--|--|
| Type number                   | Package    | ckage  |         |  |  |  |  |
|                               | Name       | Description  | Version |  |  |  |  |
| PQMB11                        | DFN1010B-6 | DFN1010B-6: plastic thermal enhanced ultra thin small outline package; no leads; 6 terminals | SOT1216 |  |  |  |  |

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### 7. Marking



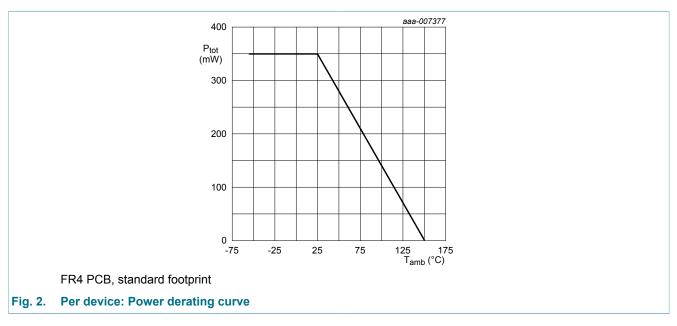
### 8. Limiting values

#### Table 5.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol           | Parameter                 | Conditions               |     | Min | Max  | Unit |
|------------------|---------------------------|--------------------------|-----|-----|------|------|
| Per transist     | tor                       |                          | '   |     |      |      |
| V <sub>CBO</sub> | collector-base voltage    | open emitter             |     | -   | -50  | V    |
| V <sub>CEO</sub> | collector-emitter voltage | open base                |     | -   | -50  | V    |
| V <sub>EBO</sub> | emitter-base voltage      | open collector           |     | -   | -10  | V    |
| VI               | input voltage             | positive                 |     | -   | 10   | V    |
|                  |                           | negative                 |     | -   | -40  | V    |
| I <sub>O</sub>   | output current            |                          |     | -   | -100 | mA   |
| I <sub>CM</sub>  | peak collector current    |                          |     | -   | -100 | mA   |
| P <sub>tot</sub> | total power dissipation   | T <sub>amb</sub> ≤ 25 °C | [1] | -   | 230  | mW   |
| Per device       |                           | 1                        |     |     |      |      |
| P <sub>tot</sub> | total power dissipation   | T <sub>amb</sub> ≤ 25 °C | [1] | -   | 350  | mW   |
| Tj               | junction temperature      |                          |     | -   | 150  | °C   |
| T <sub>amb</sub> | ambient temperature       |                          |     | -55 | 150  | °C   |
| T <sub>stg</sub> | storage temperature       |                          |     | -65 | 150  | °C   |

<sup>[1]</sup> Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

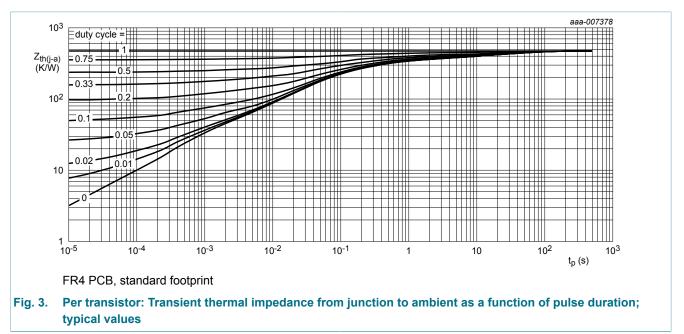


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### 9. Thermal characteristics

| Table 6. The         | rmal characteristics                              |             |     |     |     |     |      |  |
|----------------------|---|-------------|-----|-----|-----|-----|------|--|
| Symbol               | Parameter   | Conditions  |     | Min | Тур | Мах | Unit |  |
| Per transistor       | Per transistor                                    |             |     |     |     |     |      |  |
| R <sub>th(j-a)</sub> | thermal resistance<br>from junction to<br>ambient | in free air | [1] | -   | -   | 543 | K/W  |  |
| Per device           |   |             | ·   |     |     |     |      |  |
| R <sub>th(j-a)</sub> | thermal resistance<br>from junction to<br>ambient | in free air | [1] | -   | -   | 357 | K/W  |  |

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.



# **10. Characteristics**

| Symbol              | Parameter  | Conditions  |     | Min  | Тур  | Max  | Unit |
|---------------------|--|---|-----|------|------|------|------|
| Per transis         | tor  | 1   |     |      |      |      |      |
| I <sub>CBO</sub>    | collector-base cut-off current (emitter open)    | $V_{CB}$ = -50 V; I <sub>E</sub> = 0 A; T <sub>amb</sub> = 25 °C                          |     | -    | -    | -100 | nA   |
| I <sub>CEO</sub>    | collector-emitter cut-off                        | $V_{CE}$ = -30 V; I <sub>B</sub> = 0 A; T <sub>amb</sub> = 25 °C                          |     | -    | -    | -1   | μA   |
|                     | current (base open)                              | $V_{CE}$ = -30 V; I <sub>B</sub> = 0 A; T <sub>amb</sub> = 150 °C                         |     | -    | -    | -5   | μA   |
| I <sub>EBO</sub>    | emitter-base cut-off<br>current (collector open) | $V_{EB}$ = -5 V; I <sub>C</sub> = 0 A; T <sub>amb</sub> = 25 °C                           |     | -    | -    | -400 | μA   |
| h <sub>FE</sub>     | DC current gain                                  | $V_{CE}$ = -5 V; I <sub>C</sub> = -5 mA; T <sub>amb</sub> = 25 °C                         |     | 30   | -    | -    |      |
| V <sub>CEsat</sub>  | collector-emitter saturation voltage             | $I_{C}$ = -10 mA; $I_{B}$ = -0.5 mA; $T_{amb}$ = 25 °C                                    |     | -    | -    | -150 | mV   |
| V <sub>I(off)</sub> | off-state input voltage                          | $V_{CE}$ = -5 V; I <sub>C</sub> = -100 µA; T <sub>amb</sub> = 25 °C                       |     | -    | -1.1 | -0.8 | V    |
| V <sub>I(on)</sub>  | on-state input voltage                           | $V_{CE}$ = -0.3 V; I <sub>C</sub> = -10 mA; T <sub>amb</sub> = 25 °C                      |     | -2.5 | -1.8 | -    | V    |
| R1                  | bias resistor 1                                  | T <sub>amb</sub> = 25 °C  | [1] | 7    | 10   | 13   | kΩ   |
| R2/R1               | bias resistor ratio                              |   | [1] | 0.8  | 1    | 1.2  |      |
| C <sub>C</sub>      | collector capacitance                            | $V_{CB}$ = -10 V; I <sub>E</sub> = 0 A; f = 1 MHz;<br>T <sub>amb</sub> = 25 °C            |     | -    | -    | 3    | pF   |
| f <sub>T</sub>      | transition frequency                             | V <sub>CE</sub> = -5 V; I <sub>C</sub> = -10 mA; f = 100 MHz;<br>T <sub>amb</sub> = 25 °C | [2] | -    | 180  | -    | MHz  |

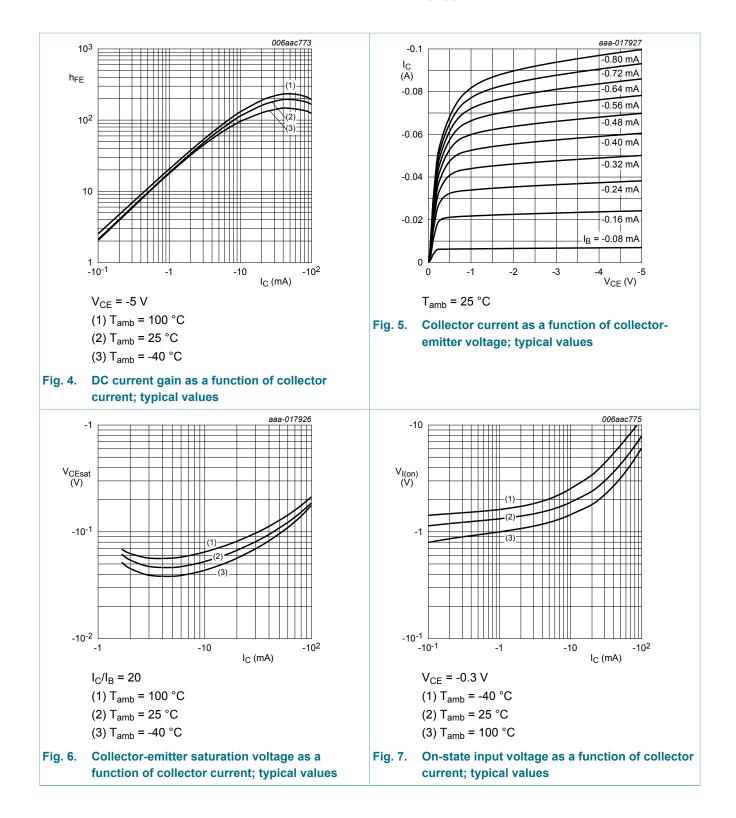
[1] See section "Test information" for resistor calculation and test conditions.

[2] Characteristics of built-in transistor

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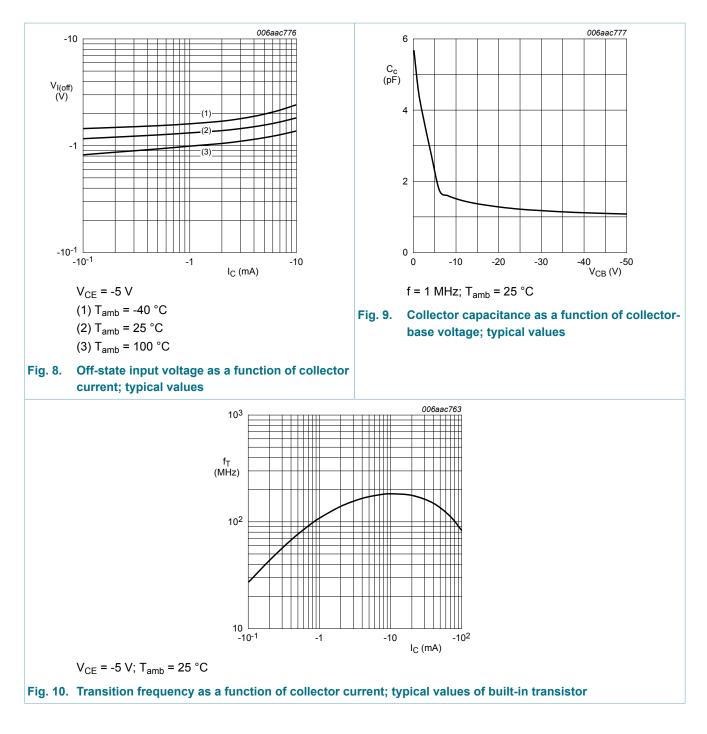
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### **11. Test information**

#### **11.1 Quality information**

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard Q101 - Stress test qualification for discrete semiconductors, and is suitable for use in automotive applications.

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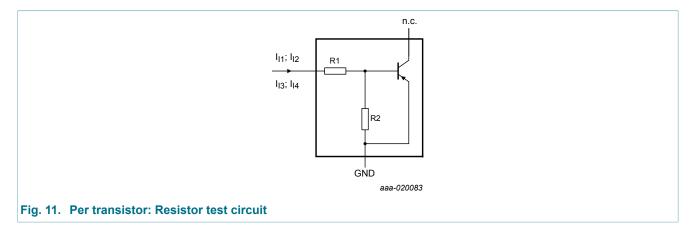
#### 11.2 Resistor calculation

• Calculation of bias resistor 1 (R1)

$$R1 = \frac{V(I_{12}) - V(I_{11})}{I_{12} - I_{11}}$$

• Calculation of bias resistor ratio (R2/R1)

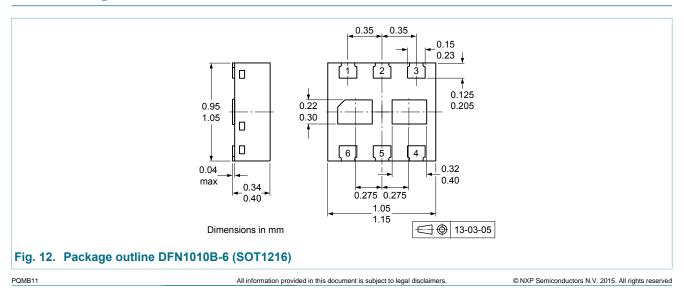
$$\frac{R2}{R1} = \frac{V(I_{14}) - V(I_{13})}{R1 \cdot (I_{14} - I_{13})} - 1$$



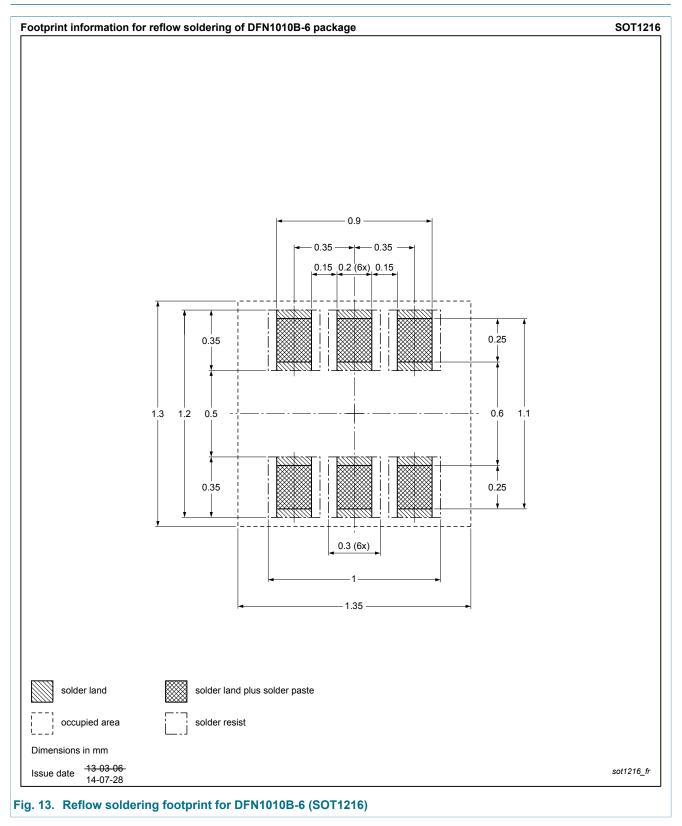
#### 11.3 Resistor test conditions

| Table 8. | <b>Resistor test conditions</b> |                 |                 |                 |                 |
|----------|---------------------------------|-----------------|-----------------|-----------------|-----------------|
| R1 (kΩ)  | R2 (kΩ)                         | Test conditions |                 |                 |                 |
|          |                                 | I <sub>I1</sub> | I <sub>12</sub> | I <sub>I3</sub> | I <sub>14</sub> |
| 10       | 10                              | -350 μA         | -450 μA         | 350 µA          | 450 µA          |

### 12. Package outline



### **13. Soldering**



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# 14. Revision history

| Table 9. Revision history |              |                    |               |            |  |  |  |
|---------------------------|--------------|--------------------|---------------|------------|--|--|--|
| Data sheet ID             | Release date | Data sheet status  | Change notice | Supersedes |  |  |  |
| PQMB11 v.1                | 20151026     | Product data sheet | -             | -          |  |  |  |

### **15. Legal information**

#### 15.1 Data sheet status

| Document status [1][2]               | Product<br>status [3] | Definition  |
|--------------------------------------|-----------------------|---|
| Objective<br>[short] data<br>sheet   | Development           | This document contains data from<br>the objective specification for product<br>development. |
| Preliminary<br>[short] data<br>sheet | Qualification         | This document contains data from the preliminary specification.                             |
| Product<br>[short] data<br>sheet     | Production            | This document contains the product specification.   |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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